

Accelerating transient fault injection campaigns by using Dynamic HDL Slicing

Bagbaba, Ahmet Cagri; Jenihhin, Maksim; Raik, Jaan; Sauer, Christian 2019 IEEE Nordic Circuits and Systems Conference (NORCAS) : NORCHIP and International Symposium of System-on-Chip (SoC), 29-30 October 2019, Helsinki, Finland : proceedings in IEEE Xplore 2019 / 7 p. : ill <https://doi.org/10.1109/NORCHIP.2019.8906932>

Active redundancy in fault tolerance : A modular switch level solution with synchronous switching

Shirodkar, Aditya; Banavath, Satish Naik; Chub, Andrii; Mandrioli, Riccardo; Ricco, Mattia 2025 IEEE Seventh International Conference on DC Microgrids (ICDCM) 2025 / 6 p <https://doi.org/10.1109/ICDCM63994.2025.11144667> [Conference at Scopus](#)

Active redundancy in isolated DC-DC converters: A modular solution for fault tolerance

Shirodkar, Aditya; Banavath, Satish Naik; Yadav, Neelesh; Chub, Andrii; Mandrioli, Riccardo 2025 IEEE 19th International Conference on Compatibility, Power Electronics and Power Engineering (CPE-POWERENG) 2025 / 5 p <https://doi.org/10.1109/CPE-POWERENG63314.2025.11027280>

AdAM: Adaptive Approximate Multiplier for Fault Tolerance in DNN Accelerators

Taheri, Mahdi; Cherezova, Natalia; Nazari, Samira; Azarpeyvand, Ali; Ghasempouri, Tara; Daneshtalab, Masoud; Raik, Jaan; Jenihhin, Maksim IEEE transactions on device and materials reliability 2024 / p. 66-75 : ill <https://doi.org/10.1109/TDMR.2024.3523386>

Adaptive Kalman filter based data aggregation in fault-resilient Underwater Sensor Networks

Vihman, Lauri; Raik, Jaan 2023 24th International Conference on Digital Signal Processing (DSP) 2023 / p. 1-5 <https://doi.org/10.1109/DSP58604.2023.10167982>

An optimization framework for dynamic pipeline management in computing systems

Naqvi, Syed Rameez; Zahid, Anjum; Sawalha, Lina; Jenihhin, Maksim Computers & electrical engineering 2019 / p. 242-258 : ill <https://doi.org/10.1016/j.compeleceng.2019.07.013> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

Analysis of fault-tolerant operation capabilities of an isolated bidirectional current-source DC–DC converter

Blinov, Andrei; Kosenko, Roman; Chub, Andrii; Ivakhno, Volodymyr Energies 2019 / art. 3203, p. 14 : ill <https://doi.org/10.3390/en12163203> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

APPRAISER : DNN fault resilience analysis employing approximation errors

Taheri, Mahdi; Ahmadilivani, Mohammad Hasan; Jenihhin, Maksim; Daneshtalab, Masoud; Raik, Jaan 2023 26th International Symposium on Design and Diagnostics of Electronic Circuits and Systems (DDECS) 2023 / p. 124–127 : ill <https://ddecs2023.taltech.ee/> <https://doi.org/10.1109/DDECS57882.2023.10139468>

Assessment and Enhancement of Hardware Reliability for Deep Neural Networks = Riistvara töökindluse hindamine ja täiustamine süvanärvivõrkude jaoks

Ahmadilivani, Mohammad Hasan 2025 https://www.ester.ee/record=b5739227*est <https://digikogu.taltech.ee/et/Item/652d50e3-773f-4de5-897d-86531feb0d56> <https://doi.org/10.23658/taltech.19/2025>

Assessment of diagnostic test for automated bug localization

Tihhomirov, Valentin; Tšepurov, Anton; Jenihhin, Maksim; Raik, Jaan; Ubar, Raimund-Johannes LATW2013 : 14th IEEE Latin-American Test Workshop, Cordoba, Argentina, April 3-5, 2013 : [proceedings] 2013 / [6] p. : ill

AWAIT : an ultra-lightweight soft-error mitigation mechanism for network-on-chip links

Janson, Karl; Pihlak, Rene; Azad, Siavoosh Payandeh; Niazmand, Behrad; Jervan, Gert; Raik, Jaan 2018 13th International Symposium on Reconfigurable Communication-centric Systems-on-Chip (ReCoSoC), Lille, France, July 9th-11th, 2018 2018 / p. 1-6 : ill <https://doi.org/10.1109/ReCoSoC.2018.8449374>

Combining fault analysis technologies for ISO26262 functional safety verification

Augusto da Silva, Felipe; Bagbaba, Ahmet Cagri; Hamdioui, Said; Sauer, Christian 2019 IEEE 28th Asian Test Symposium (ATS) : 10–13 December 2019, Kolkata, India : proceedings 2019 / p. 129–134 : ill <https://doi.org/10.1109/ATS47505.2019.00024>

Component based development of hybrid control systems

Vain, Jüri; Kuusik, Alar; Kääramees, Marko Proceedings of the 15th International Conference on CAD/CAM, Robotics & Factories of the Future CARSAMPFOF'99 : August 18-20, 1999, Aguas de Lindoia, Brasil. Vol. 2 1999 / p. RW5-1 - RW5-6 https://www.researchgate.net/publication/2611129_Component_Based_Development_of_Hybrid_Control_Systems

Controlled bidirectional DC circuit breaker with zero negative current for high load shift applications

Raghavendra I, Venkata; Naik, Satish B.; Sreekanth, Thamballa; Chub, Andrii IEEE transactions on industry applications 2022 / p. 6942-6951 <https://doi.org/10.1109/TIA.2022.3193345> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

Cooperative scheduler to enhance massive connectivity in 5G and beyond by minimizing interference in OMA and NOMA

Mwakwata, Collins Burton; Elgarhy, Osama Mohamed Mostafa; Alam, Muhammad Mahtab; Le Moullec, Yannick; Päränd, Sven; Trichias, Konstantinos; Ramantas, Kostas IEEE Systems Journal 2022 / p. 5044-5055

Cost-effective fault tolerance for CNNs using parameter vulnerability based hardening and pruning

Ahmadilivani, Mohammad Hasan; Mousavi, Seyedhamidreza; **Raik, Jaan; Daneshtalab, Masoud; Jenihhin, Maksim** 2024 IEEE 30th International Symposium on On-line Testing and Robust System Design (IOLTS) : IOLTS 2024 : July 03rd-05th 2024, Rennes, Brittany, France 2024 / 7 p <https://doi.org/10.1109/IOLTS60994.2024.10616072> Article at Scopus Article at WOS

Data-driven fault-resilient cross-layer sensor network architecture = Andmepõhine tõrkekindel kihtideülene sensorvõrgu arhitektuur

Vihman, Lauri 2024 https://www.ester.ee/record=b5657135*est <https://digikogu.taltech.ee/et/Item/00a93258-dc0f-4a4d-822f-099fff757224> <https://doi.org/10.23658/taltech.7/2024>

DeepVigor: Vulnerability Value RanGes and FactORs for DNNs' Reliability Assessment

Ahmadilivani, Mohammad Hasan; Taheri, Mahdi; Raik, Jaan; Daneshtalab, Masoud; Jenihhin, Maksim IEEE European Test Symposium (ETS) : Venice, Italy, 22-26 May 2023 : proceedings 2023 / 6 p. : ill <https://doi.org/10.1109/ETS56758.2023.10174133>

Description of digital objects with alternative graphs for test generation purposes

Ubar, Raimund-Johannes; Lohuaru, Tõnu Fault Tolerant Systems and Diagnostics : XI. International Conference ; Proceedings ; Suhl, June 6-9, 1988 1988 / p. [?]

Design and test technology for dependable systems-on-chip

2011 https://www.ester.ee/record=b4467408*est

Effective scalable IEEE 1687 instrumentation network for fault management

Jutman, Artur; Shibin, Konstantin; Devadze, Sergei IEEE design & test 2013 / p. 26-35 : ill <https://doi.org/10.1109/MDAT.2013.2278535> Journal metrics at Scopus Article at Scopus Journal metrics at WOS Article at WOS

Efficient fault injection based on dynamic HDL slicing technique

Bagbaba, Ahmet Cagri; Jenihhin, Maksim; Raik, Jaan; Sauer, Christian 2019 IEEE 25th International Symposium on On-Line Testing and Robust System Design (IOLTS 2019) : 1-3 July 2019, Greece 2019 / p. 52-53 : ill <https://doi.org/10.1109/IOLTS.2019.8854419>

Elektriliiniseadmed madalpingepaigaldistes [Võrguteavik] : raadiohäiringute tunnussuurused. Piirväärtused ja mõõtemetodid. Osa 1, Majasisene aparatuur = Power line communication apparatus used in low-voltage installations : radio disturbance characteristics. Limits and methods of measurement. Part 1, Apparatus for in-home use

2015 http://www.ester.ee/record=b4460215*est

Elektromagnetiline ühilduvus

Risthein, Endel 2006 https://www.ester.ee/record=b2175290*est

Elektromagnetiline ühilduvus. Osa 6-2, Erialased põhistandardid. Häiringutaluvus tööstuskeskkondades [Võrguteavik] = Electromagnetic compatibility (EMC). Part 6-2, Generic standards. Immunity standard for industrial environments (IEC 61000-6-2:2016)

2019 https://www.ester.ee/record=b5205860*est

Enhancing fault resilience of QNNs by selective neuron splitting

Ahmadilivani, Mohammad Hasan; Taheri, Mahdi; Raik, Jaan; Daneshtalab, Masoud; Jenihhin, Maksim 2023 IEEE 5th International Conference on Artificial Intelligence Circuits and Systems (AICAS) 2023 / 5 p. : ill <https://doi.org/10.1109/AICAS57966.2023.10168633>

Fault diagnosis and identification of malfunctioning protection devices in a power system via time series similarity matching

Xu, Bing; Wang, Chongyu; **Wen, Fushuan; Palu, Ivo;** Pang, Kaiyuan Energy Conversion and Economics 2020 / p. 81-92 <https://doi.org/10.1049/enc2.12008>

Fault diagnosis of output-side diode-bridge in isolated DC-DC series resonant converter

Bakeer, Abualkasim Ahmed Ali; Chub, Andrii; Vinnikov, Dmitri 2022 IEEE 7th International Energy Conference (ENERGYCON) 2022 <https://doi.org/10.1109/ENERGYCON53164.2022.9830339>

Fault management instrumentation network based on IEEE P1687 IJTAG

Shibin, Konstantin; Jutman, Artur; Devadze, Sergei European Test Symposium (ETS), 2013, Avignon, France 2013

Fault tolerance in integration interfaces of business software

Lemmik, Rivo; Karjust, Kristo; Otto, Tauno International Journal Of Scientific Knowledge (Computing and Information Technology) IJSK 2014 / p. 35-43 : ill

Fault tolerant control and diagnosis strategies for cartesian industrial robot motion control planning system = Tõrketaluvusega juhtimis- ja diagnostikastrateegiad tööstusliku karteesianroboti liikumise planeerimise juhtimissüsteemi jaoks

Autsou, Siarhei 2025 https://www.ester.ee/record=b5734587*est <https://digikogu.taltech.ee/et/Item/c9afdbf3-354b-41f5-a705-ed924a2af21>
<https://doi.org/10.23658/taltech.14/2025>

Fault tolerant control of a grid-connected microgrid with high penetration of renewable energy

Senanayaka, Jagath; Khang, Huynh Van; **Vaimann, Toomas; Rassõlkin, Anton** 24th International Conference on Electrical Machines and Systems (ICEMS) 2021 / p. 938-943 <https://doi.org/10.23919/ICEMS52562.2021.9634364>

Fault-tolerant high step-up DC-DC converters

Chub, Andrii 19th International Symposium "Topical problems in the field of electrical and power engineering. Doctoral school of energy and geotechnology. III" : Tartu, Estonia, January 14-17, 2020 2020 / p. 67-68 : ill https://www.ester.ee/record=b5291755*est

Fault-tolerant soft-switching current-fed DC-DC converter

Zinchenko, Denys; Kosenko, Roman; Blinov, Andrei; Vinnikov, Dmitri 2019 IEEE 2nd Ukraine Conference on Electrical and Computer Engineering : UKRCON-2019 : conference proceedings 2019 / p. 437-440 : ill <https://doi.org/10.1109/UKRCON.2019.8879973>

FESDA : fog-enabled secure data aggregation in smart grid IoT network

Saleem, Ahsan; Khan, Abid; Malik, Saif Ur Rehman; Pervaiz, Haris; **Malik, Hassan**; Alam, Masoom; Jindal, Anish IEEE Internet of Things Journal 2020 / p. 6132-6142 <https://doi.org/10.1109/JIOT.2019.2957314> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

FORTUNE: A Negative Memory Overhead Hardware-Agnostic Fault Tolerance Technique in DNNs

Nazari, Samira; **Taheri, Mahdi**; Azarpeyvand, Ali; Afsharchi, Mohsen; **Ghasempouri, Tara**; Herglotz, Christian; **Daneshtalab, Masoud; Jenihhin, Maksim** 2024 IEEE 33rd Asian Test Symposium (ATS) 2024 / p. 1-6 : ill <https://doi.org/10.1109/ATS64447.2024.10915463> [Conference proceedings at Scopus](#) [Article at Scopus](#) [Article at WOS](#)

FP7 DIAMOND : design error diagnosis and correction success stories

Raik, Jaan; Jenihhin, Maksim; Könighofer, Robert European Test Symposium (ETS), 2013, Avignon, France 2013 / p. 1-6

Handling of SETs on NoC links by exploitation of inherent redundancy in circular input buffers [Online resource]

Janson, Karl; Pihlak, Rene; Azad, Siavoosh Payandeh; Niazmand, Behrad; Jervan, Gert; Raik, Jaan BEC 2018 : 2018 16th Biennial Baltic Electronics Conference (BEC) : proceedings of the 16th Biennial Baltic Electronics Conference, October 8-10, 2018 2018 / 4 p.: ill <https://doi.org/10.1109/BEC.2018.8600989>

Health management for self-aware SoCs based on IEEE 1687 infrastructure

Shibin, Konstantin; Devadze, Sergei; Jutman, Artur; Grabmann, Martin; Pricken, Robin IEEE Design & Test 2017 / p. 27-35 : ill <https://doi.org/10.1109/MDAT.2017.2750902> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

Heterogeneous Approximation of DNN HW Accelerators based on Channels Vulnerability

Cherezova, Natalia; Pappalardo, Salvatore; **Taheri, Mahdi**; **Ahmadilivani, Mohammad Hasan**; Deveautour, Bastien; Bosio, Alberto; **Raik, Jaan; Jenihhin, Maksim** 2024 IFIP/IEEE 32nd International Conference on Very Large Scale Integration (VLSI-SoC) 2024 / 4 p. : ill <https://doi.org/10.1109/VLSI-SoC62099.2024.10767798> [Conference proceedings at Scopus](#) [Article at Scopus](#)

A hierarchical approach for devising area efficient concurrent online checkers

Niazmand, Behrad; Azad, Siavoosh Payandeh; Ghasempouri, Tara; Raik, Jaan; Jervan, Gert Proceedings 2nd IEEE International Test Conference in Asia : ITC-Asia 2018, 15-17 August 2018, Harbin, China 2018 / p. 139-144 : ill <https://doi.org/10.1109/ITC-Asia.2018.00034>

Hierarchical calculation of malicious faults for evaluating the fault-tolerance

Ubar, Raimund-Johannes; Devadze, Sergei; Jenihhin, Maksim; Raik, Jaan; Jervan, Gert; Ellervee, Peeter Proceedings : Fourth IEEE International Symposium on Electronic Design, Test and Applications : [DELTA 2008] : 23-25 January 2008, Hong Kong, SAR, China 2008 / p. 222-227 : ill <https://ieeexplore.ieee.org/document/4459544>

Hybrid DC-DC converters with topology morphing control and post-fault operation capability

Vinnikov, Dmitri; Chub, Andrii; Korkh, Oleksandr; Blinov, Andrei; Liivik, Elizaveta Electrimacs 2019 : Selected Papers, Vol. 1 2020 / p. 433-445 https://doi.org/10.1007/978-3-030-37161-6_33 [Conference proceeding at Scopus](#) [Article at Scopus](#)

Improving legibility of motor current spectrum for broken rotor bars fault diagnostics

Asad, Bilal; Vaimann, Toomas; Kallaste, Ants; Rassõlkin, Anton; Belahcen, Anouar; Iqbal, Muhammad Naveed Scientific Journal of Riga Technical University. Electrical, control and communication engineering 2019 / p. 1-8 : ill <https://doi.org/10.2478/ecce-2019-0001>

Infoedastus pidevate signaalidega : õppevahend. I osa, Pidevate signaalide edastus ja häirekindlus

Eiskop, Ilmar 1978 https://www.ester.ee/record=b1274915*est

Integration of iUML-B and UPPAAL timed automata for development of real-time systems with concurrent processes

Shokri-Manninen, Fatima; **Tsiopoulos, Leonidas**; **Vain, Jüri**; Walden, Marina Rigorous State-Based Methods 7th International Conference, ABZ 2020, Ulm, Germany, May 27–29, 2020 : proceedings 2020 / p. 186-202 https://doi.org/10.1007/978-3-030-48077-6_13 [Conference proceedings at Scopus](#) [Article at Scopus](#)

Intelligent diagnostic centers: a new way to distributed fault-tolerance

Varkonyi-Koczy, Annamaria R.; Tilly, K.; Dobrowiecki, Tadeusz; Vadasz, B.; Kiss, I. BEC : Baltic Electronics Conference : proceedings of the 4th Biennial Conference, October 9-14, 1994, Tallinn (Estonia). 1 1994 / p. 365-368: ill

International summer school on real-time, fault-tolerance and artificial intelligence : Neeruti, June 30 - July 2, 1992

Vain, Jüri Eesti Teaduste Akadeemia Toimetised. Füüsika. Matemaatika 1992 / 4, lk. 288-290

Invited paper: System-Wide Fault Management based on IEEE P1687 IJTAG

Jutman, Artur; **Devadze, Sergei**; **Aleksejev, Jevgeni** 6th International Workshop on Reconfigurable Communication-centric Systems-on-Chip (ReCoSoC) : 20-22 June 2011, Montpellier, France 2011 / [4] p.: ill <https://ieeexplore.ieee.org/document/5981520>

Juhusliku algfaasiga impulss-signaali optimaalne vastuvõtt ja häirekindlus

Müürsepp, Ivo Ringhääling 2003 : X rahvusvahelise telekommunikatsioonipäeva materjalid 2003 / lk. 90-97 : ill

Kodeerimine

Madar, Urve; **Puusepp, Peeter** 2000 https://www.ester.ee/record=b1445483*est

Machine learning to tackle the challenges of transient and soft errors in complex circuits

Lange, Thomas; **Balakrishnan, Aneesh**; Glorieux, Maximilien; Alexandrescu, Dan; Sterpone, Luca 2019 IEEE 25th International Symposium on On-Line Testing and Robust System Design (IOLTS), 1-3 July 2019, Greece 2019 / p. 7-14 : ill <https://doi.org/10.1109/IOLTS.2019.8854423>

Mathematical modeling and experimental validation of a fault-tolerant dual stator LHEFSM for rail transit applications

Ullah, Basharat; Khan, Faisal; **Hussain, Shahid**; Albogamy, Fahad R. IEEE Access 2024 / p. 121586-121595 : ill <https://doi.org/10.1109/ACCESS.2024.3452984> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

Mixed-level identification of fault redundancy in microprocessors

Oyeniran, Adeboye Stephen; **Ubar, Raimund-Johannes**; **Jenihhin, Maksim**; **Gürsoy, Cemil Cem**; **Raik, Jaan** LATS 2019 : 20th IEEE Latin American Test Symposium : Santiago, Chile, March 11th - 13th 2019 2019 / 6 p. : ill <https://doi.org/10.1109/LATW.2019.8704591>

Motor failure tolerant control system with self diagnostics for unmanned multirotors

Ambroziak, Leszek; **Simha, Ashutosh**; Pawluszewicz, Ewa; Kotta, Ülle 2019 24th International Conference on Methods and Models in Automation and Robotics (MMAR) 2019 / p. 422–427 : ill <https://doi.org/10.1109/MMAR.2019.8864726>

Observer-based residual generation for nonlinear discrete-time systems

Kaldmäe, Arvo; **Kotta, Ülle** Proceedings of the Estonian Academy of Sciences 2018 / p. 325-336 <https://doi.org/10.3176/proc.2018.4.01> http://www.kirj.ee/public/proceedings_pdf/2018/issue_4/proc-2018-4-325-336.pdf [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

Reliability-critical computation offloading in UAV swarms

Rahbari, Dadmehr; **Ahmed, Foisal**; **Jenihhin, Maksim**; **Alam, Muhammad Mahtab**; **Le Moullec, Yannick** IEEE Systems Journal 2024 / p. 1871-1882 <https://doi.org/10.1109/JSYST.2024.3432449> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

SAFFIRA: a Framework for Assessing the Reliability of Systolic-Array-Based DNN Accelerators

Taheri, Mahdi; **Daneshtalab, Masoud**; **Raik, Jaan**; **Jenihhin, Maksim**; Pappalardo, Salvatore; Jimenez, Paul; Deveautour, Bastien; Bosio, Alberto 2024 27th International Symposium on Design & Diagnostics of Electronic Circuits & Systems (DDECS) : 03-05 April 2024, Kielce, Poland 2024 / p. 19–24 : ill <https://doi.org/10.1109/DDECS60919.2024.10508925>

Self-healing photovoltaic microconverter with zero redundancy and accurate low-cost fault detection

Bakeer, Abualkasim Ahmed Ali; **Chub, Andrii**; **Vinnikov, Dmitri** IEEE transactions on industrial electronics 2024 / p. 646-656 <https://doi.org/10.1109/TIE.2023.3250836> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

Short-circuit fault detection and remedial in full-bridge rectifier of series resonant DC-DC converter based on inductor voltage signature

Bakeer, Abualkasim Ahmed Ali; **Chub, Andrii**; **Vinnikov, Dmitri** 2020 IEEE 61st International Scientific Conference on Power and Electrical Engineering of Riga Technical University (RTUCON), Riga, Latvia, Nov. 5-7, 2020 : conference proceedings 2020 / 6 p. : ill <https://doi.org/10.1109/RTUCON51174.2020.9316482>

Specification of hybrid components of control systems

Vain, Jüri; Kuusik, Alar; Kääramees, Marko Preprints of the 5th IFAC Workshop on Intelligent Manufacturing Systems IMS'98, November 9-11 1998, Gramado - RS, Brazil 1998 / p. 83-88: ill <https://www.sciencedirect.com/science/article/pii/S147466701741007X>

Spectrum analysis for condition monitoring and fault diagnosis of ventilation motor : a case study

Shabbir, Noman; Kütt, Lauri; Asad, Bilal; Jawad, Muhammad; Iqbal, Muhammad Naveed; Daniel, Kamran Energies 2021 / art. 2001 <https://doi.org/10.3390/en14072001> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

A systematic literature review on hardware reliability assessment methods for deep neural networks

Ahmadilivani, Mohammad Hasan; Taheri, Mahdi; Raik, Jaan; Daneshtalab, Masoud; Jenihhin, Maksim ACM Computing Surveys 2024 / art. 141, 39 p. : ill <https://doi.org/10.1145/3638242> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

Systematic review of fault tolerant techniques in underwater sensor networks

Vihman, Lauri; Kruusmaa, Maarja; Raik, Jaan Sensors 2021 / art. 3264 <https://doi.org/10.3390/s21093264> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

System-wide fault management based on IEEE P1687 IJTAG

Shibin, Konstantin; Jutman, Artur; Devadze, Sergei Info- ja kommunikatsioonitehnoloogia doktorikooli IKTDK kuuenda aastakonverentsi artiklite kogumik : 3.-5. oktoobril 2012, Laulasmaa 2012 / p. 81-84 : ill

Zero-memory-overhead clipping-based fault tolerance for LSTM deep neural networks

Parchekani, Bahram; Nazari, Samira; Ahmadilivani, Mohammad Hasan; Azarpeyvand, Ali; Raik, Jaan; Ghasempouri, Tara; Daneshtalab, Masoud 37th IEEE International Symposium on Defect and Fault Tolerance in VLSI and Nanotechnology Systems, Harwell, Oxfordshire, Didcot, UK, October 8th - 10th, 2024 2024 / 4 p. : ill <https://doi.org/10.1109/DFT63277.2024.10753533> [Conference proceedings at Scopus](#) [Article at Scopus](#) [Article at WOS](#)

Tallinna Tehnikaülikooli uus energeetikalabor

Aro, Rein Elektriala 2018 / lk. 27 : fot http://www.ester.ee/record=b1240496*est https://artiklid.elnet.ee/record=b2868795*est

TalTech avas energeetikalabori

Ehitaja 2018 / lk. 30 : fot http://www.ester.ee/record=b1072123*est

TalTechi uues energeetikalaboris saab testida elektrisüsteemide töökindlust

Mente et Manu 2018 / lk. 9 : fot http://www.ester.ee/record=b1242496*est <http://dea.digar.ee/publication/AKmenteetmanu> https://www.ttu.ee/public/m/mente-et-manu/MM_05_2018/mobile/index.html

Tarkvara tõrketaluvus

Petermann, Viktor; **Paluoja, Rein** A & A 2000 / 4, lk. 36-44 https://artiklid.elnet.ee/record=b1004809*est

Tõrketaluvus kommertsarvutisüsteemides

Petermann, Viktor; **Paluoja, Rein** A & A 2000 / 5, lk. 7-17 : ill https://artiklid.elnet.ee/record=b1005190*est

Understanding fault-tolerance vulnerabilities in advanced SoC FPGAs for critical applications

Cherezova, Natalia; Shibin, Konstantin; Jenihhin, Maksim; Jutman, Artur Microelectronics reliability 2023 / art. 115010, 10 p. : ill <https://doi.org/10.1016/j.microrel.2023.115010> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

Wide input voltage range high step-up DC-DC converter with fault-tolerant operation capability

Vinnikov, Dmitri; Chub, Andrii; Korkh, Oleksandr; Kouro, Samir 2019 IEEE International Conference on Industrial Technology, ICIT 2019 : Melbourne, Australia, 13-15 February 2019 : proceedings 2019 / p. 1099-1104 : ill <https://doi.org/10.1109/ICIT.2019.8755040> [Conference proceedings at Scopus](#) [Article at Scopus](#) [Article at WOS](#)

Анализ помехоустойчивости многоуровневых каскадных кодов в среде MATLAB

Madar, Urve; Sinjuk, Aleksei; Lossmann, Eerik Elektronika ir elektrotehnika = Electronics and electrical engineering 2004 / p. 71-74 : ill

К вычислению изменения интенсивности отказов элементов по изменениям температуры и нагрузки

Koort, Ants Тезисы докладов Республиканской научно-технической конференции "Современные методы и устройства радиоэлектронного оборудования", посвященной Дню радио. [2], Секция: Компьютерный анализ сигналов и цепей 1981 / с. 9-10 https://www.ester.ee/record=b1310795*est

Помехоустойчивость и динамика фазовых процессов в синхронных измерительных преобразователях : автореферат ... кандидата технических наук (05.11.05)

Min, Mart 1984 https://www.ester.ee/record=b2083669*est

Пути повышения помехоустойчивости лазерных атмосферных систем связи

Hinrikus, Hiie Применение лазеров в системах преобразования, передачи и обработки информации : Материалы

краткосрочного семинара (12-13 дек.) 1978 / с. 15-16

Ускорение определения параметров безотказности элементов радиотехнических схем

Koort, Ants Тезисы докладов Республиканской научно-технической конференции "Современные методы и устройства радиоэлектронного оборудования", посвященной Дню радио. [2], Секция: Компьютерный анализ сигналов и цепей 1981 / с. 7-8
https://www.eester.ee/record=b1310795*est